

Application/Control No.	Applicant(s)/Patent under Reexamination
10/751,716	DE MOL VAN OTTERLOO, MAARTEN JOOST
Examiner	Art Unit

Steven S. Paik

2876

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST			
Text search			
partially searched: cl. 235; 283; 399	9/29/2005	SSP	
updated .	3/18/2006	SSP	